

VNP35N07FI VNB35N07/VNV35N07

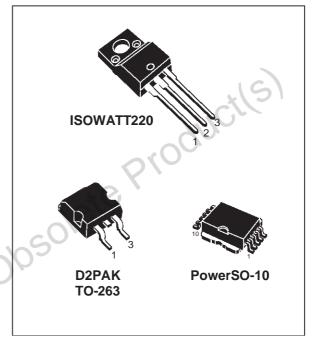
"OMNIFET": FULLY AUTOPROTECTED POWER MOSFET

TYPE	V _{clamp}	R _{DS(on)}	l _{lim}
VNP35N07FI	70 V	0.028 Ω	35 A
VNB35N07	70 V	0.028 Ω	35 A
VNV35N07	70 V	0.028 Ω	35 A

- LINEAR CURRENT LIMITATION
- THERMAL SHUT DOWN
- SHORT CIRCUIT PROTECTION
- INTEGRATED CLAMP
- LOW CURRENT DRAWN FROM INPUT PIN
- DIAGNOSTIC FEEDBACK THROUGH INPUT PIN
- ESD PROTECTION
- DIRECT ACCESS TO THE GATE OF THE POWER MOSFET (ANALOG DRIVING)
- COMPATIBLE WITH STANDARD POWER MOSFET

DESCRIPTION

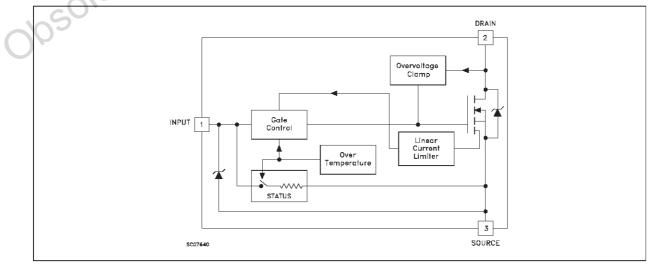
The VNP35N07FI, VNB35N07 and VNV35N07 are monolithic devices made using STMicroelectronics VIPower M0 Technology, intended for replacement of standard power MOSFETS in DC to 50 KHz applications. Built-in thermal shut-down, linear current limitation and overvoltage clamp protect the chip in harsh



enviroments.

Fault feedback can be detected by monitoring the voltage at the input pin.

BLOCK DIAGRAM (*)



(*) PowerSO-10 Pin Configuration : INPUT = 6,7,8,9,10; SOURCE = 1,2,4,5; DRAIN = TAB

September 2013

ABSOLUTE MAXIMUM RATING

Symbol	Parameter	Va	lue	Unit
		PowerSO-10 D2PAK	ISOWATT220	
V _{DS}	Drain-source Voltage (V _{in} = 0)	Internally	Clamped	V
Vin	Input Voltage	1	V	
ID	Drain Current	Internally	y Limited	Α
I _R	Reverse DC Output Current	-5	Α	
Vesd	Electrostatic Discharge (C= 100 pF, R=1.5 KΩ)	20	00	V
P _{tot}	Total Dissipation at $T_c = 25$ °C	125	40	W
Tj	Operating Junction Temperature	Internally	/ Limited	°C
Tc	Case Operating Temperature	Internally	y Limited	°C
T _{stg}	Storage Temperature	-55 ti	o 150	°C
HERMA	L DATA	8	1001	

THERMAL DATA

					ISOWATT220	PowerSO-10	D2PAK	
			Junction-case	Max	3.12	1	1	°C/W
$R_{thj-amb}$	Thermal	Resistance	Junction-ambient	Мах	62.5	50	62.5	°C/W
					6			

ELECTRICAL CHARACTERISTICS ($T_{case} = 25 \,^{\circ}C$ unless otherwise specified) OFF

Symbol	Parameter	C Test Conditions	Min.	Тур.	Max.	Unit
Vclamp	Drain-source Clamp Voltage	$I_D = 200 \text{ mA}$ $V_{in} = 0$	60	70	80	V
V _{CLTH}	Drain-source Clamp Threshold Voltage	$I_D = 2 \text{ mA} V_{in} = 0$	55			V
VINCL	Input-Source Reverse Clamp Voltage	l _{in} = -1 mA	-1		-0.3	V
I _{DSS}	Zero Input Voltage Drain Current (V _{in} = 0)				50 200	μΑ μΑ
liss	Supply Current from Input Pin	$V_{DS} = 0 V V_{in} = 10 V$		250	500	μA

ON (*)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
VIN(th)	Input Threshold Voltage	$V_{DS} = V_{in}$ $I_D + I_{in} = 1 \text{ mA}$	0.8		3	V
$R_{DS(on)}$	Static Drain-source On Resistance				0.028 0.035	Ω Ω

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g _{fs} (*)	Forward Transconductance	V _{DS} = 13 V I _D = 18 A	20	25		S
C _{oss}	Output Capacitance	$V_{DS} = 13 \text{ V} f = 1 \text{ MHz} V_{in} = 0$		980	1400	pF

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ELECTRICAL CHARACTERISTICS (continued)

SWITCHING (**)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on Delay Time	$V_{DD} = 28 V$ $I_d = 18 A$		100	200	ns
tr	Rise Time	$V_{gen} = 10 V$ $R_{gen} = 10 \Omega$		350	600	ns
t _{d(off)}	Turn-off Delay Time	(see figure 3)		650	1000	ns
t _f	Fall Time			200	350	ns
t _{d(on)}	Turn-on Delay Time	V _{DD} = 28 V I _d = 18 A		500	800	ns
tr	Rise Time	$V_{gen} = 10 V$ $R_{gen} = 1000 \Omega$		2.7	4.2	μs
t _{d(off)}	Turn-off Delay Time	(see figure 3)		10	16	μs
t _f	Fall Time			4.3	6.5	μs
(di/dt) _{on}	Turn-on Current Slope	V _{DD} = 28 V I _D = 18 A		60		A/μs
		$V_{in} = 10 V$ $R_{gen} = 10 \Omega$				5
Qi	Total Input Charge	$V_{DD} = 12 \text{ V}$ $I_D = 18 \text{ A}$ $V_{in} = 10 \text{ V}$		100	C	nC

SOURCE DRAIN DIODE

Qi	Total Input Charge	$V_{DD} = 12 V$ $I_D = 18 A$ $V_{in} = 10 V$		100	(\cdot, \cdot)	nC
SOURCE	DRAIN DIODE		~	091		
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Vsd (*)	Forward On Voltage	Isp = 18 A Vin = 0			1.6	V
trr(**)	Reverse Recovery Time	$I_{SD} = 18 \text{ A}$ di/dt = 100 A/µs V _{DD} = 30 V $T_i = 25 \text{ °C}$		250		ns
Qrr(**)	Reverse Recovery	(see test circuit, figure 5)		1		μC
I _{RRM} (**)	Charge Reverse Recovery Current	000		8		А

PROTECTION

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
l _{lim}	Drain Current Limit		25 25	35 35	45 45	A A
t _{dlim} (**)	Step Response Current Limit	V _{in} = 10 V V _{in} = 5 V		35 70	60 140	μs μs
T _{jsh} (**)	Overtemperature Shutdown		150			°C
T _{jrs} (**)	Overtemperature Reset		135			°C
l _{gf} (**)	Fault Sink Current			50 20		mA mA
E _{as} (**)	Single Pulse Avalanche Energy	starting T _j = 25 °C V _{DD} = 20 V V _{in} = 10 V R _{gen} = 1 K Ω L = 10 mH	2.5			J

(*) Pulsed: Pulse duration = 300 μs , duty cycle 1.5 % (**) Parameters guaranteed by design/characterization

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PROTECTION FEATURES

During normal operation, the Input pin is electrically connected to the gate of the internal power MOSFET. The device then behaves like a standard power MOSFET and can be used as a switch from DC to 50 KHz. The only difference from the user's standpoint is that a small DC current ($I_{\rm ISS}$) flows into the Input pin in order to supply the internal circuitry.

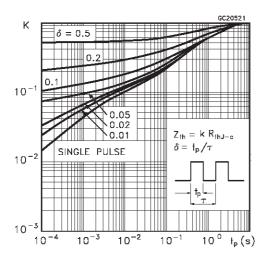
The device integrates:

- OVERVOLTAGE CLAMP PROTECTION: internally set at 70V, along with the rugged avalanche characteristics of the Power MOSFET stage give this device unrivalled ruggedness and energy handling capability. This feature is mainly important when driving inductive loads.
- LINEAR CURRENT LIMITER CIRCUIT: limits the drain current ld to llim whatever the Input pin voltage. When the current limiter is active, the device operates in the linear region, so power dissipation may exceed the capability of the heatsink. Both case and junction temperatures increase, and if this phase lasts long enough, junction temperature may reach the overtemperature threshold T_{jsh}.
- OVERTEMPERATURE AND SHORT CIRCUIT PROTECTION: these are based on sensing the chip temperature and are not dependent on the input voltage. The location of the sensing element on the chip in the power stage area ensures fast, accurate detection of the junction temperature. Overtemperature cutout occurs at minimum 150°C. The device is automatically restarted when the chip temperature falls below 135°C.
- STATUS FEEDBACK: In the case of an overtemperature fault condition, a Status Feedback is provided through the Input pin. The internal protection circuit disconnects the input from the gate and connects it instead to ground via an equivalent resistance of 100 Ω . The failure can be detected by monitoring the voltage at the Input pin, which will be close to ground potential.

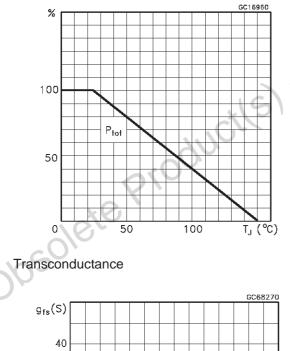
Additional features of this device are ESD protection according to the Human Body model and the ability to be driven from a TTL Logic circuit (with a small increase in $R_{DS(on)}$).

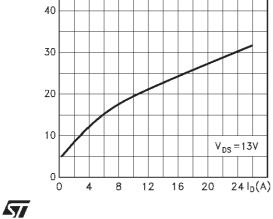
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Thermal Impedance For ISOWATT220

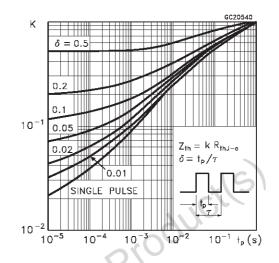


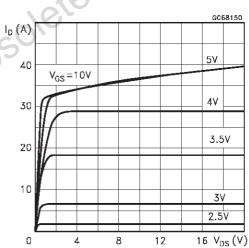
Derating Curve



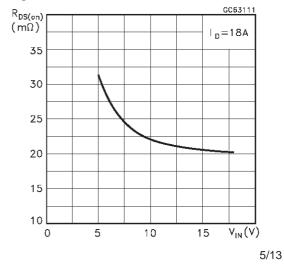


Thermal Impedance For D2PAK / PowerSO-10



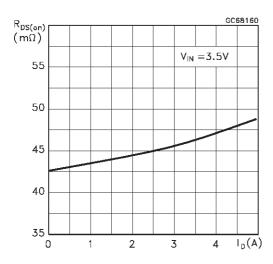


Static Drain-Source On Resistance vs Input Voltage

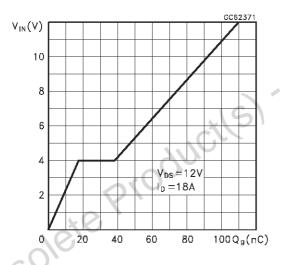


Output Characteristics

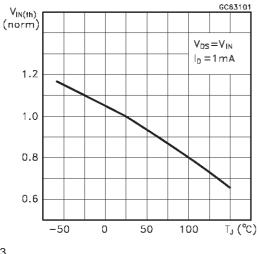
Static Drain-Source On Resistance



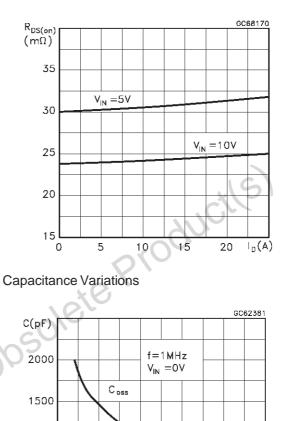
Input Charge vs Input Voltage

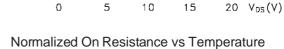


Normalized Input Threshold Voltage vs Temperature









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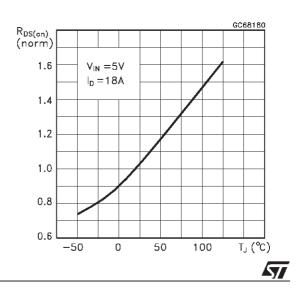
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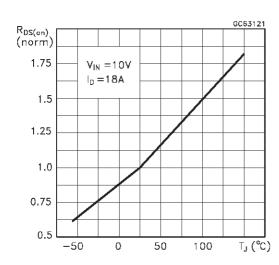
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 $V_{DS}(V)$

1000

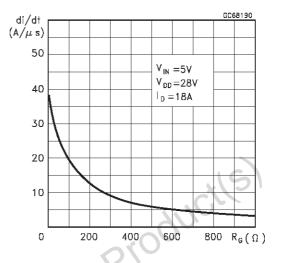
500



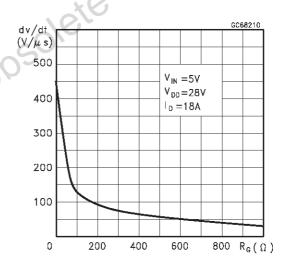


Normalized On Resistance vs Temperature

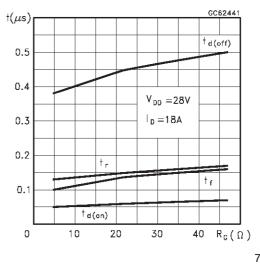
Turn-on Current Slope



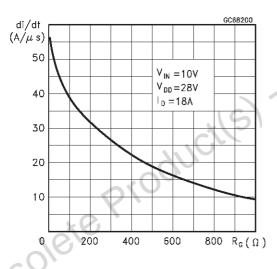
Turn-off Drain-Source Voltage Slope



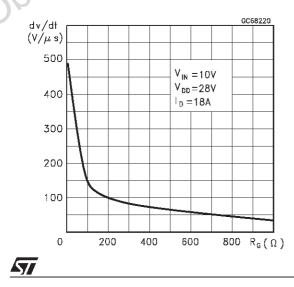




Turn-on Current Slope

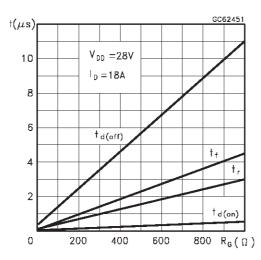




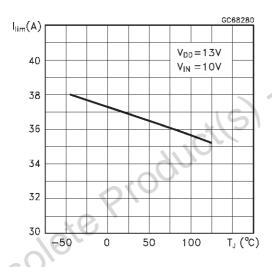


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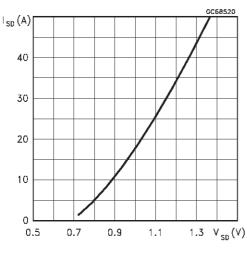
Switching Time Resistive Load



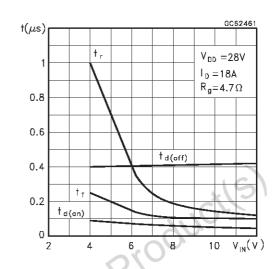
Current Limit vs Junction Temperature



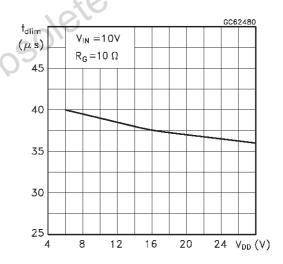
Source Drain Diode Forward Characteristics



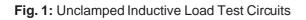
Switching Time Resistive Load



Step Response Current Limit



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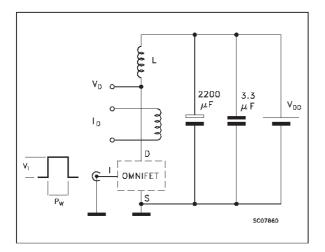


Fig. 3: Switching Times Test Circuits For Resistive Load

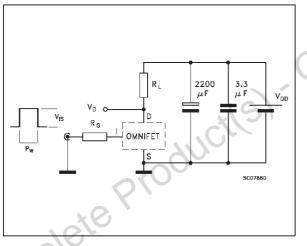


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times

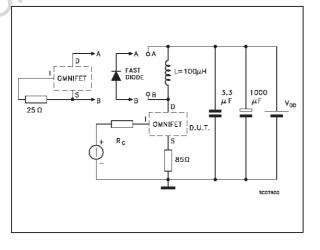
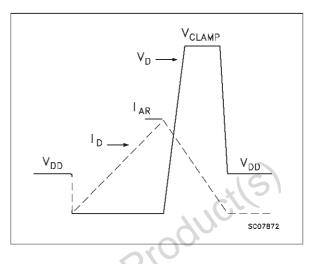


Fig. 2: Unclamped Inductive Waveforms





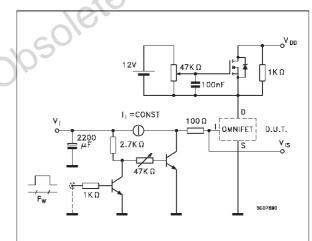
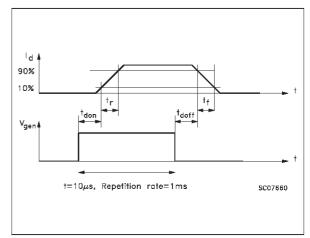


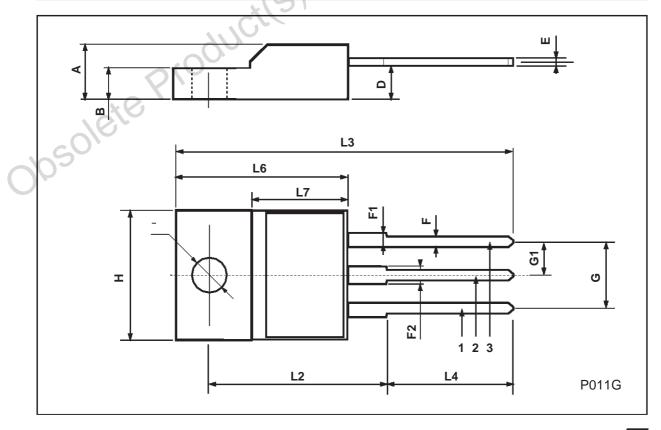
Fig. 6: Waveforms



VNP35N07FI-VNB35N07-VNV35N07

DIM.		mm		inch			
DINI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	4.4		4.6	0.173		0.181	
В	2.5		2.7	0.098		0.106	
D	2.5		2.75	0.098		0.108	
E	0.4		0.7	0.015		0.027	
F	0.75		1	0.030		0.039	
F1	1.15		1.7	0.045		0.067	
F2	1.15		1.7	0.045		0.067	
G	4.95		5.2	0.195		0.204	
G1	2.4		2.7	0.094	h^{0}	0.106	
Н	10		10.4	0.393	K `	0.409	
L2		16		XO	0.630		
L3	28.6		30.6	1.126		1.204	
L4	9.8		10.6	0.385		0.417	
L6	15.9		16.4	0.626		0.645	
L7	9		9.3	0.354		0.366	
Ø	3		3.2	0.118		0.126	

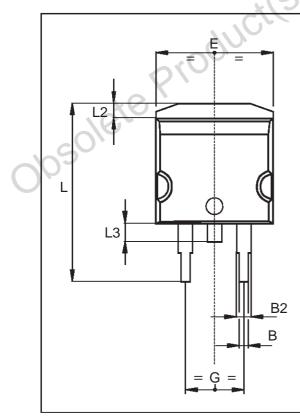
ISOWATT220 MECHANICAL DATA

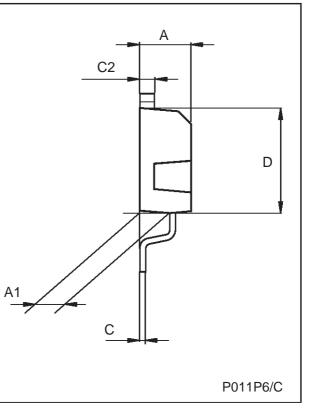


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DIM.		mm		inch			
Dim	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.	
А	4.3		4.6	0.169		0.181	
A1	2.49		2.69	0.098		0.106	
В	0.7		0.93	0.027		0.036	
B2	1.25		1.4	0.049		0.055	
С	0.45		0.6	0.017		0.023	
C2	1.21		1.36	0.047	du	0.053	
D	8.95		9.35	0.352	26	0.368	
E	10		10.28	0.393		0.404	
G	4.88		5.28	0.192		0.208	
L	15		15.85	0.590		0.624	
L2	1.27		1.4	0.050		0.055	
L3	1.4		1.75	0.055		0.068	

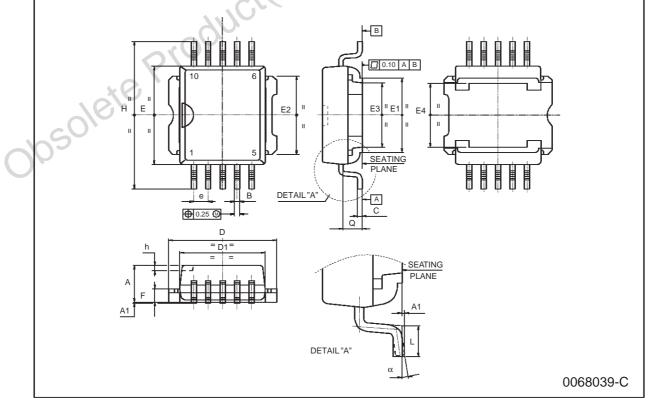
TO-263 (D2PAK) MECHANICAL DATA





DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	3.35		3.65	0.132		0.144
A1	0.00		0.10	0.000		0.004
В	0.40		0.60	0.016		0.024
С	0.35		0.55	0.013		0.022
D	9.40		9.60	0.370		0.378
D1	7.40		7.60	0.291		0.300
Е	9.30		9.50	0.366		0.374
E1	7.20		7.40	0.283		0.291
E2	7.20		7.60	0.283		0.300
E3	6.10		6.35	0.240	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~	0.250
E4	5.90		6.10	0.232		0.240
е		1.27		×	0.050	
F	1.25		1.35	0.049		0.053
Н	13.80		14.40	0.543		0.567
h		0.50			0.002	
L	1.20		1.80	0.047		0.071
q		1.70			0.067	
α	0 ⁰		8°			

PowerSO-10 MECHANICAL DATA



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